

## N-Channel Enhancement Mode Power MOSFET

#### **DESCRIPTION**

The MPTIIH€ uses advanced trench technology and design to provide excellent R<sub>DS(ON)</sub> with low gate charge. It can be used in a wide variety of applications.

#### **GENERAL FEATURES**

● V<sub>DS</sub> =30V,I<sub>D</sub> =18A

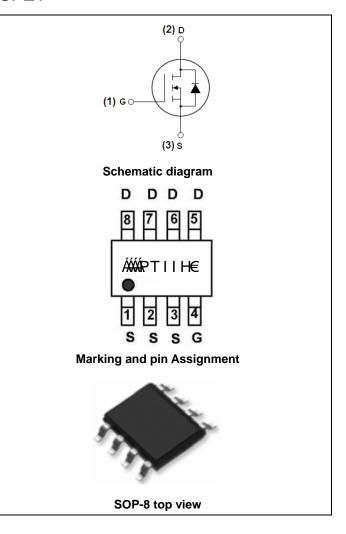
 $R_{DS(ON)}$  < 7.5m $\Omega$  @  $V_{GS}$  =10V

 $R_{DS(ON)}$  < 10m $\Omega$  @  $V_{GS}$ =5V

- High density cell design for ultra low Rdson
- Fully characterized Avalanche voltage and current

#### **Application**

- Power switching application
- Hard Switched and High Frequency Circuits
- Uninterruptible Power Supply



### **Package Marking And Ordering Information**

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Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
PTIIH€	ÁÁPTIIH€ÁÁ	SOP-8	Ø330mm	12mm	2500 units

### Absolute Maximum Ratings (TA=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	30	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Drain Current-Continuous	I <sub>D</sub>	18	А
Drain Current-Continuous(T <sub>A</sub> =100℃)	I <sub>D</sub> (100℃)	13	Α
Pulsed Drain Current	I <sub>DM</sub>	50	Α
Maximum Power Dissipation	P <sub>D</sub>	3	W
Operating Junction and Storage Temperature Range	$T_{J}, T_{STG}$	-55 To 150	$^{\circ}$ C

#### **Thermal Characteristic**

Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{ heta JA}$	42	°C/W
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# Electrical Characteristics (TA=25°Cunless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit	
Off Characteristics							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250μA		33	-	V	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =30V,V <sub>GS</sub> =0V	-	-	1	μA	
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA	
On Characteristics (Note 3)							
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$	1	1.6	3	V	
	Б	V <sub>GS</sub> =10V, I <sub>D</sub> =9A	-	5.5	7.5	mΩ	
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =5V, I <sub>D</sub> =9A	-	7.5	10		
Forward Transconductance	<b>g</b> FS	V <sub>DS</sub> =5V,I <sub>D</sub> =18A	5	-	-	S	
Dynamic Characteristics (Note4)	-		<b>.</b>	Į.			
Input Capacitance	C <sub>lss</sub>	\/ 45\/\\ 0\/	-	2100	-	PF	
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ =15V, $V_{GS}$ =0V, F=1.0MHz	-	460	-	PF	
Reverse Transfer Capacitance	C <sub>rss</sub>	F=1.UMHZ	-	230	-	PF	
Switching Characteristics (Note 4)							
Turn-on Delay Time	t <sub>d(on)</sub>		-	20	-	nS	
Turn-on Rise Time	t <sub>r</sub>	$V_{DD}$ =10 $V$ , $I_{D}$ =9 $A$	-	15	-	nS	
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =10 $V$ , $R_{GEN}$ =2.7 $\Omega$	-	60	-	nS	
Turn-Off Fall Time	t <sub>f</sub>		-	10	-	nS	
Total Gate Charge	Qg	\/ -40\/   -40 \	-	41	-	nC	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}=10V,I_{D}=10A,$	-	14	-	nC	
Gate-Drain Charge	Q <sub>gd</sub>	V <sub>GS</sub> =10V	-	11	-	nC	
Drain-Source Diode Characteristics	<u>.</u>						
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =9A	-	-	1.2	V	
Diode Forward Current (Note 2)	Is		-	-	18	Α	

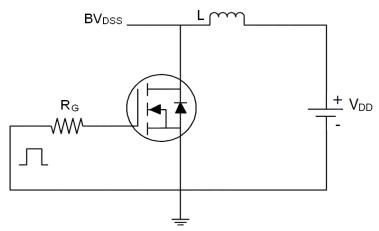
#### Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board,  $t \le 10$  sec.
- 3. Pulse Test: Pulse Width  $\leq$  300 $\mu$ s, Duty Cycle  $\leq$  2%.
- **4.** Guaranteed by design, not subject to production

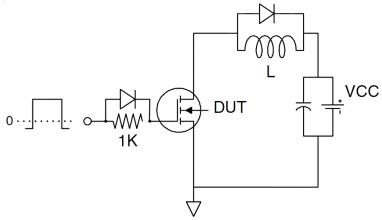


# **Test circuit**

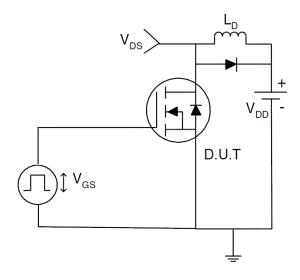
# 1) E<sub>AS</sub> test Circuits



## 2) Gate charge test Circuit:



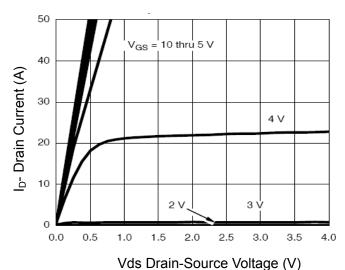
### 3) Switch Time Test Circuit:



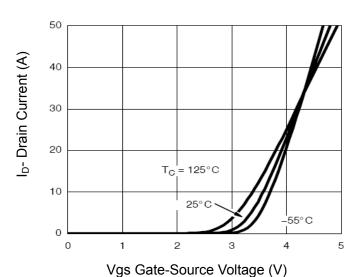




# TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (Curves)



**Figure 1 Output Characteristics** 



**Figure 2 Transfer Characteristics** 

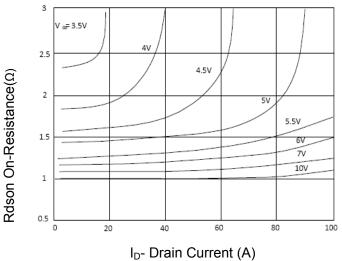


Figure 3 Rdson- Drain Current

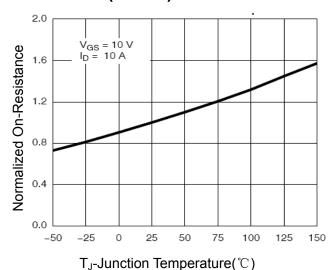


Figure 4 Rdson-JunctionTemperature

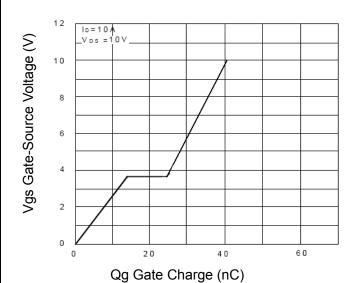


Figure 5 Gate Charge

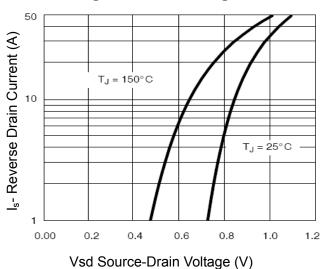


Figure 6 Source- Drain Diode Forward



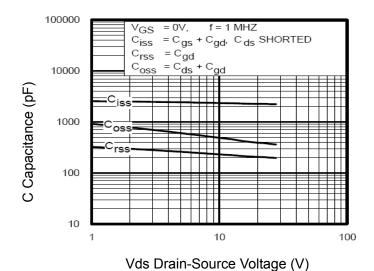
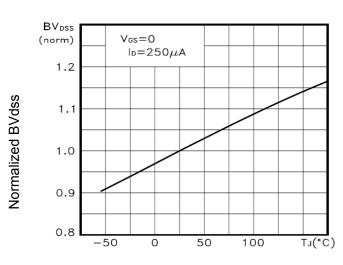
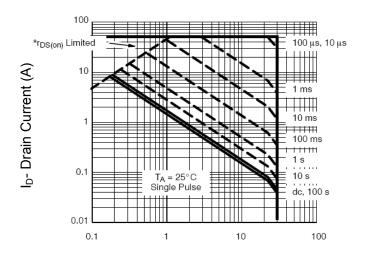


Figure 7 Capacitance vs Vds



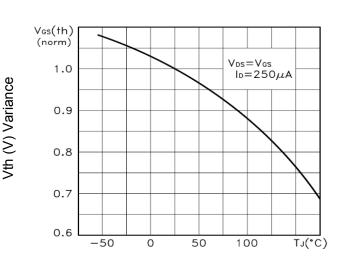
T<sub>J</sub>-Junction Temperature(°C)

Figure 9 BV<sub>DSS</sub> vs Junction Temperature



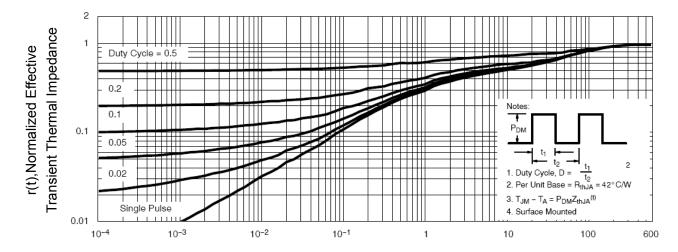
Vds Drain-Source Voltage (V)

Figure 8 Safe Operation Area



T<sub>J</sub>-Junction Temperature(°C)

Figure 10 V<sub>GS(th)</sub> vs Junction Temperature

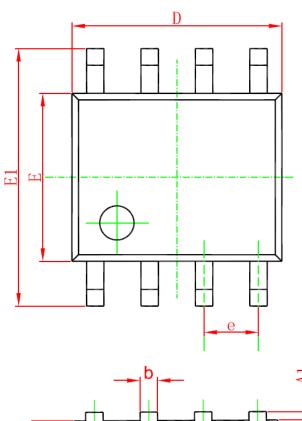


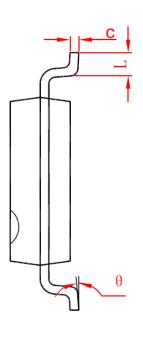
Square Wave Pluse Duration(sec)

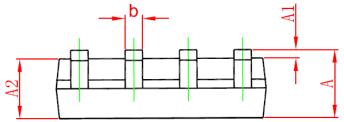
**Figure 11 Normalized Maximum Transient Thermal Impedance** 



# **SOP-8 PACKAGE IN FORMATION**







Ch l	Dimensions Ir	n Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
A	1. 350	1. 750	0. 053	0. 069	
A1	0. 100	0. 250	0.004	0. 010	
A2	1. 350	1. 550	0.053	0. 061	
b	0. 330	0. 510	0. 013	0. 020	
С	0. 170	0. 250	0.006	0. 010	
D	4. 700	5. 100	0. 185	0. 200	
Е	3. 800	4. 000	0. 150	0. 157	
E1	5. 800	6. 200	0. 228	0. 244	
е	1. 270 (BSC)		0. 050 (BSC)		
L	0. 400	1. 270	0. 016	0. 050	
θ	0°	8°	0°	8°	



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